

Product Change Notification: MFOL-20RLLB058

Date:

02-Jul-2025

Product Category:

Linear Regulators, Power Management - System Supervisors/Voltage Detectors

Notification Subject:

CCB 7584 Final Notice: Qualification of UNIG as an additional final test location and scan and pack for selected MIC5350, MIC5332, MIC5331, and MIC2793 device families available in 8L UDFN (2x2x0.6mm) package.

Affected CPNs:

MFOL-20RLLB058_Affected_CPN_07022025.pdf MFOL-20RLLB058_Affected_CPN_07022025.csv

PCN Status: Final Notification

PCN Type: Manufacturing Change

Microchip Parts Affected: Please open one of the files found in the Affected CPNs section. Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

Description of Change: Qualification of UNIG as an additional final test location and scan and pack for selected MIC5350, MIC5332, MIC5331, and MIC2793 device families available in 8L UDFN (2x2x0.6mm) package.

Pre and Post Summary Changes:

	Pre Change	Post Change			
Final Test Site	Unisem Chengdu Co.,Ltd.	Unisem Chengdu Co.,Ltd.	Unisem Gopeng		
Scan and Pack Site	(UNIC)	(UNIC)	(UNIG)		
Carrier Tape	With minor dimensional change. See Pre and Post change summary for comparison.				

Cover Tape	With minor dimensional change. See Pre and Post change summary for comparison.		
Reel	With minor dimensional change. See Pre and Post change summary for comparison.		
Packing Method/Material	See Pre and Post change for comparison.		

Impacts to Datasheet: None

Change Impact: None

Reason for Change: To improve manufacturability and on-time delivery performance by qualifying UNIG as an additional final test site and scan and pack site.

Change Implementation Status: In Progress

Estimated First Ship Date: 28 July 2025 (date code: 2531)

Note Below EFSD: Note: Please be advised that after the estimated first ship date customers may

receive pre and post change parts.

Timetable Summary:

	May 2025			^	July 2025						
Work Week	18	19	20	21	22		27	28	29	30	31
Initial PCN Issue Date				X							
Qual Report Availability							X				
Final PCN Issue Date							X				
Estimated implementation Date											X

Method to Identify Change: Traceability Code

Qualification Report: Please open the attachments included with this PCN labeled as

PCN # Qual Report.

Revision History: May 23, 2025: Issued initial notification.

July 2, 2025: Issued final notification. Attached the Qualification Report. Provided the estimated first ship date to be on July 28, 2025.

Note: The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable product.

Attachments:

PCN_MFOL-20RLLB058_Pre and Post Change Summary.pdf PCN_MFOL-20RLLB058_Qualification Report.pdf

Please contact your local Microchip sales office with questions or concerns regarding this notification.

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If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our <u>PCN</u> <u>home page</u> select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the <u>PCN FAQ</u> section.

If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

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Affected Catalog Part Numbers (CPN)

MIC2793NH-04VMT-T5

MIC2793LH-04VMT-TR

MIC5350-SGYMT-TR

MIC5332-PMYMT-TR

MIC5332-NNYMT-TR

MIC5332-J4YMT-TR

MIC5350-SMYMT-TR

MIC5350-PGYMT-TR

MIC5350-MMYMT-TR

MIC5350-MGYMT-TR

MIC5331-G4YMT-TR

MIC5332-SSYMT-TR

MIC5332-SSYMT-T5

MIC5332-PPYMT-TR

MIC5332-PNYMT-TR

MIC5332-MNYMT-TR

MIC5332-MMYMT-TR

MIC5332-G4YMT-TR

MIC5331-PPYMT-TR

MIC5331-PNYMT-TR

MIC5331-PMYMT-TR

MIC5331-NNYMT-TR

MIC5331-MNYMT-TR

MIC5331-MMYMT-TR

MIC5331-J4YMT-TR

MIC2793LH-04VMT-T5

MIC2793NH-04VMT-TR

Date: Sunday, June 29, 2025

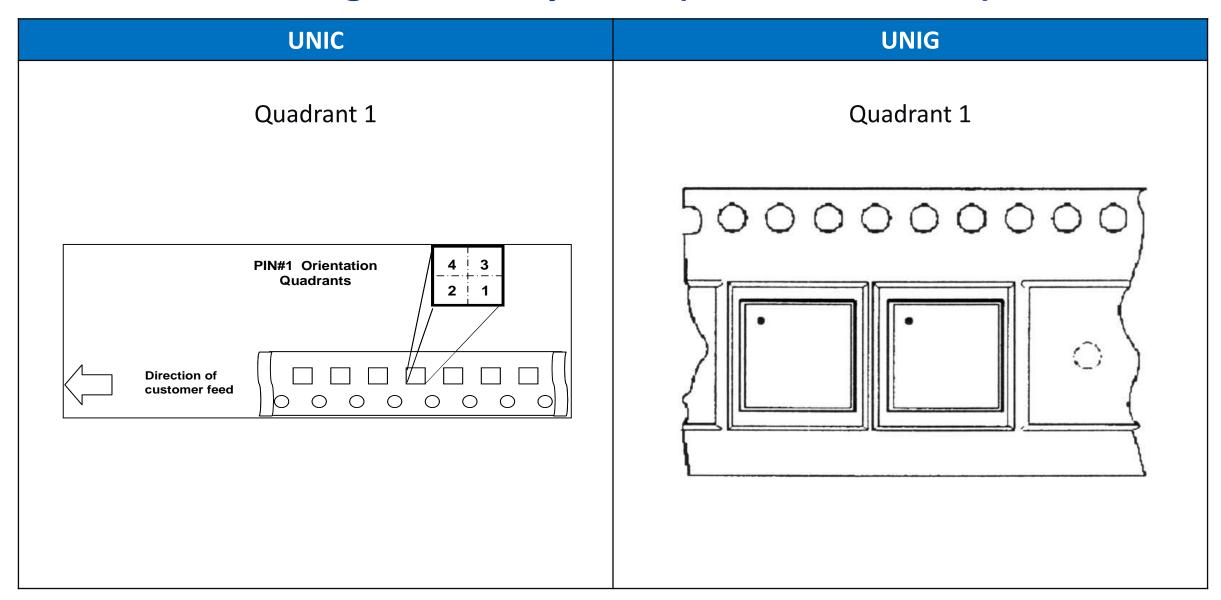
CCB 7584 Pre and Post Change Summary PCN #: MFOL-20RLLB058



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Pre and Post Change Summary – T/R (Pin1 Orientation)



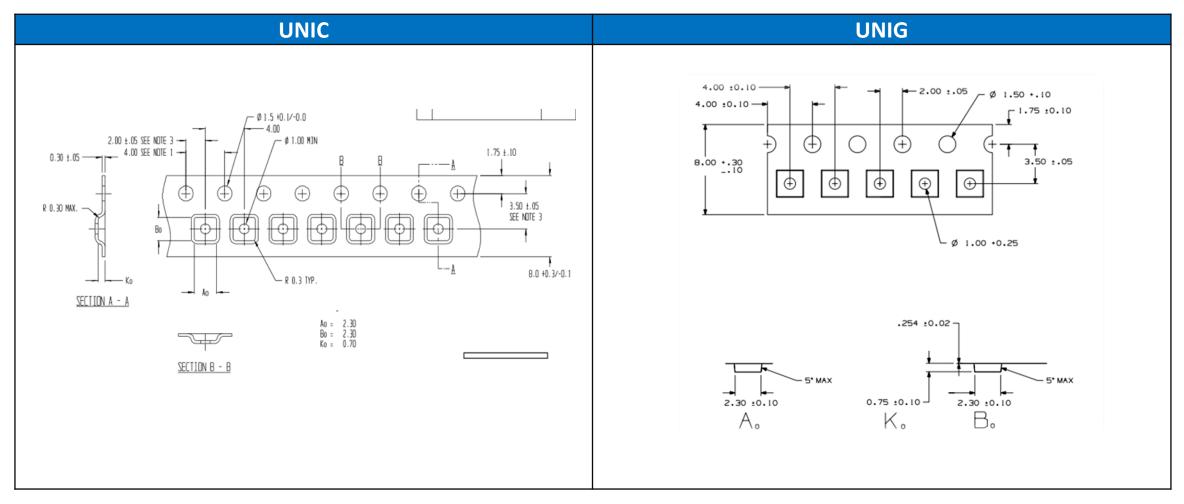


Pre and Post Change Summary – T/R (BQM)

UNIC	UNIG
5000/Reel for 'TR' Suffix	5000/Reel for 'TR' Suffix
500/Reel for 'T5' Suffix	500/Reel for 'T5' Suffix



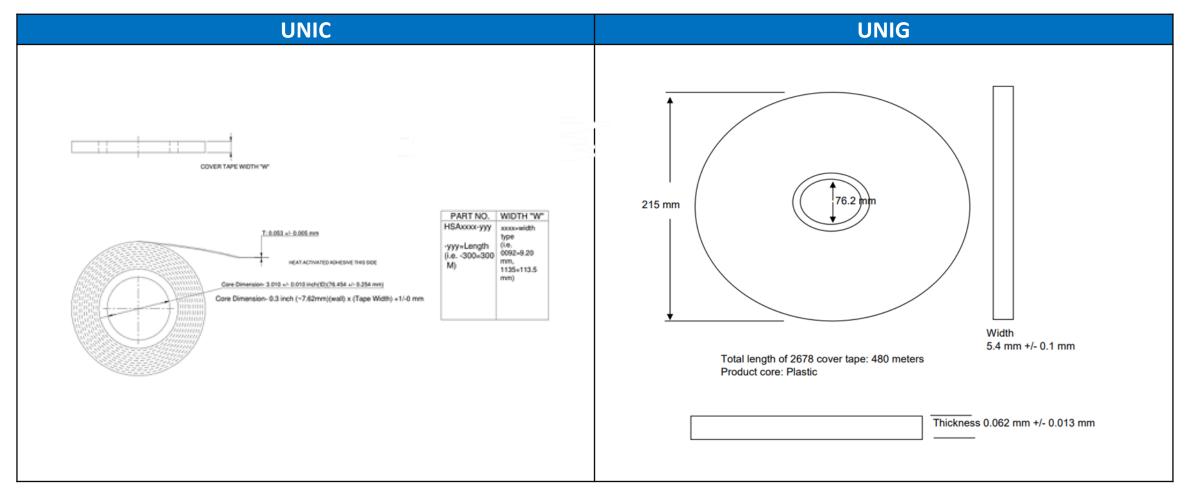
Pre and Post Change Summary – T/R (Carrier Tape)



Plant	W (mm)	P (mm)	A0 (mm)	B0 (mm)	K0 (mm)	Thickness (mm)
UNIC	8	4	2.3	2.3	0.7	0.3
UNIG	8	4	2.3	2.3	0.75	0.254



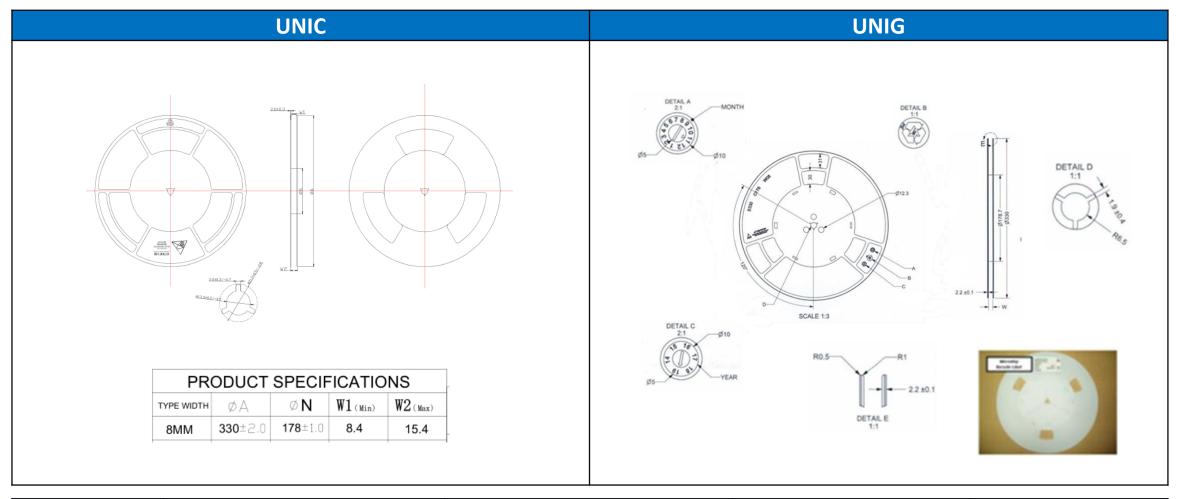
Pre and Post Change Summary – T/R (Cover Tape)



Plant	Width W (mm)	Width W (mm) Thickness T (mm) Color		Sealing Methodology
UNIC	5.4	0.053	Transparent	Heat sealing
UNIG	5.4	0.062	Transparent	Heat Sealing



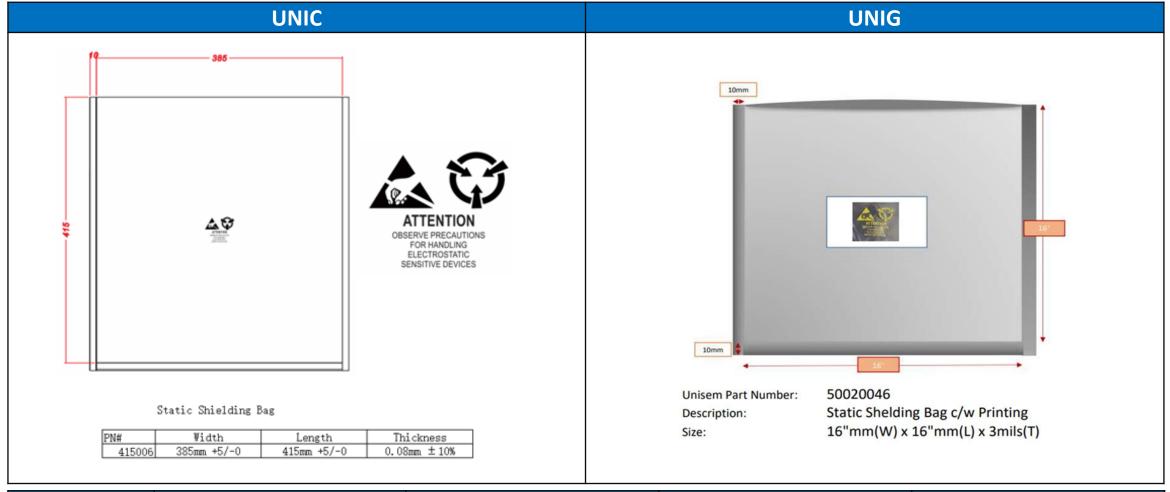
Pre and Post Change Summary – T/R (Reel)



Plant	Reel Diameter (mm)	Reel Hub Size (mm)	Reel Width Max (mm)	Color
UNIC	330	178	15.4	White
UNIG	330	178	8.4	White



Pre and Post Change Summary – T/R (Bag)



Plant	Bag type	Length (mm)	Width (mm)	Thickness (mm)
UNIC	Static Shielding Bag	415 +/5-0	385 +/5-0	0.08 +/-10%
UNIG	Antistatic Shield Bag	406.4	406.4	3



Pre and Post Change Summary – T/R (Packing Method for MSL-1 Pack)







PCN #: MFOL-20RLLB058

Date: June 24, 2025

Qualification of UNIG as an additional final test location and scan and pack for selected MIC5350, MIC5332, MIC5331, and MIC2793 device families available in 8L UDFN (2x2x0.6mm) package.

Purpose: Qualification of UNIG as an additional final test location and scan and pack for selected MIC5350, MIC5332, MIC5331, and MIC2793 device families available in 8L UDFN (2x2x0.6mm) package.

CCB No.: 7584

Test Name	Test Conditions	Sample Size	Qty of Lots	Fail/Accept Criteria	Result
Bin and Yield Comparison	Test the same units at existing and destination locations and compare Bin and Yield data.	3000	1	≤0.1%	Passed
Parametric / Characterization Comparison	Characterize the same units at existing and destination locations and compare data.	33	1	≤10%	Passed
Correlation Lot report	Yield at each step and reject analysis between systems. 33 units are tested as lot correlation Accept on yield match within 0.1%	33	1	≤0.1%	Passed